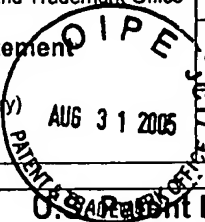


Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-211001	Application No. 10/774,700
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date February 10, 2004	Group Art Unit 2818

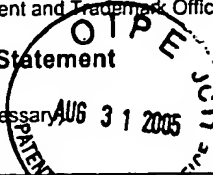


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							Yes	No

Examiner Signature <i>[Signature]</i>	Date Considered 09/27/05
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